

PROCEEDINGS OF SPIE

Frontiers in Ultrafast Optics: Biomedical, Scientific, and Industrial Applications XXIII

**Peter R. Herman
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Editors

**29–31 January 2023
San Francisco, California, United States**

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Published by
SPIE

Volume 12411

Proceedings of SPIE 0277-786X, V. 12411

SPIE is an international society advancing an interdisciplinary approach to the science and application of light.

Frontiers in Ultrafast Optics: Biomedical, Scientific, and Industrial Applications XXIII, edited by
Peter R. Herman, Roberto Osellame, Adela Ben-Yakar, Proc. of SPIE Vol. 12411, 1241101
© 2023 SPIE · 0277-786X · doi: 10.1117/12.2679005

Proc. of SPIE Vol. 12411 1241101-1

The papers in this volume were part of the technical conference cited on the cover and title page. Papers were selected and subject to review by the editors and conference program committee. Some conference presentations may not be available for publication. Additional papers and presentation recordings may be available online in the SPIE Digital Library at SPIDigitalLibrary.org.

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Please use the following format to cite material from these proceedings:

Author(s), "Title of Paper," in *Frontiers in Ultrafast Optics: Biomedical, Scientific, and Industrial Applications XXIII*, edited by Peter R. Herman, Roberto Osellame, Adela Ben-Yakar, Proc. of SPIE 12411, Seven-digit Article CID Number (DD/MM/YYYY); (DOI URL).

ISSN: 0277-786X
ISSN: 1996-756X (electronic)

ISBN: 9781510659278
ISBN: 9781510659285 (electronic)

Published by

SPIE

P.O. Box 10, Bellingham, Washington 98227-0010 USA

Telephone +1 360 676 3290 (Pacific Time)

SPIE.org

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